Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
	TSUMURA ET AL.	
Examiner	Art Unit	
Marc S. Zimmer	1712	

	SEAR	CHED	
Class	Subclass	Date	Examiner
		•	
			•
	-		

INTERFERENCE SEARCHED						
Subclass	Date	Examiner				

SEARCH (INCLUDING SEAR	NOTES CH STRA	TEGY)	
	DA	TE	EXMR
EAST (see attached)	1/29/	2007	MZ
·	•		•
			_
	-	:	